

CY7C1012AV33

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Selection Guide

Description	-8	Unit	
Maximum Access Time	8	ns	
Maximum Operating Current	Commercial	300	mA
	Industrial	300	
Maximum CMOS Standby Current	Commercial / Industrial	50	mA

Pin Configurations

	1	2	3	4	5	6	7
Α	NC	А	A	A	A	А	NC
В	NC	А	A	CE ₀	Α	А	NC
С	I/O ₁₂	NC	CE ₁	NC	CE ₂	NC	I/O ₀
D	I/O ₁₃	V_{DD}	V _{SS}	V _{SS}	V _{SS}	V_{DD}	I/O ₁
E	I/O ₁₄	V_{SS}	V _{DD}	V _{SS}	V _{DD}	V_{SS}	I/O ₂
F	I/O ₁₅	V_{DD}	V _{SS}	V _{SS}	V _{SS}	V_{DD}	I/O ₃
G	I/O ₁₆	V _{SS}	V _{DD}	V _{SS}	V _{DD}	V_{SS}	I/O ₄
н	I/O ₁₇	V_{DD}	V _{SS}	V _{SS}	V _{SS}	V_{DD}	I/O ₅
J	NC	V _{SS}	V _{DD}	V _{SS}	V _{DD}	V_{SS}	DNU
К	I/O ₁₈	V_{DD}	V _{SS}	V _{SS}	V _{SS}	V_{DD}	I/O ₆
L	I/O ₁₉	V_{SS}	V _{DD}	V _{SS}	V _{DD}	V_{SS}	I/O ₇
м	I/O ₂₀	V_{DD}	V _{SS}	V _{SS}	V _{SS}	V_{DD}	I/O ₈
N	I/O ₂₁	V _{SS}	V _{DD}	V _{SS}	V _{DD}	V_{SS}	I/O ₉
Р	I/O ₂₂	V_{DD}	V_{SS}	V _{SS}	V_{SS}	V_{DD}	I/O ₁₀
R	I/O ₂₃	А	NC	NC	NC	А	I/O ₁₁
Т	NC	А	A	WE	Α	А	NC
U	NC	А	A	OE	А	А	NC

Figure 1. 119-ball PBGA pinout (Top View) [1, 2]

Notes
 NC pins are not connected on the die.
 DNU pins have to be left floating or tied to VSS to ensure proper application.



Maximum Ratings

Exceeding maximum ratings may shorten the useful life of the device. User guidelines are not tested.

Storage Temperature	–65 °C to +150 °C
Ambient Temperature with Power Applied	–55 °C to +125 °C
Supply Voltage on V_{CC} to Relative GND ^[3]	–0.5 V to +4.6 V

DC Voltage Applied to Outputs	3
DC Voltage Applied to Outputs in high Z State ^[3]	–0.5 V to V _{CC} + 0.5 V
DC Input Voltage [3]	–0.5 V to V _{CC} + 0.5 V
Current into Outputs (LOW)	

Operating Range

Range	V _{cc}	
Commercial	0 °C to +70 °C	$3.3~V\pm0.3~V$
Industrial	–40 °C to +85 °C	

DC Electrical Characteristics

Over the Operating Range

Parameter	Description	Test Conditio	Test Conditions ^[4]			Unit
Farameter	Description	Test Conduit	Min	Max	Unit	
V _{OH}	Output HIGH Voltage	V_{CC} = Min, I_{OH} = -4.0 mA		2.4	-	V
V _{OL}	Output LOW Voltage	V _{CC} = Min, I _{OL} = 8.0 mA		-	0.4	V
V _{IH}	Input HIGH Voltage			2.0	V _{CC} + 0.3	V
V _{IL} ^[3]	Input LOW Voltage					V
I _{IX}	Input Leakage Current	$GND \le V_I \le V_{CC}$		-1	+1	μA
I _{OZ}	Output Leakage Current	$GND \leq V_{OUT} \leq V_{CC}$, Output	GND \leq V _{OUT} \leq V _{CC} , Output Disabled			μA
I _{CC}	V _{CC} Operating Supply Current	V _{CC} = Max,	Commercial	-	300	mA
		$f = f_{MAX} = 1/t_{RC}$	Industrial	-	300	mA
I _{SB1}	Automatic CE Power-down Current – TTL Inputs	$ \begin{array}{l} \mbox{Max V}_{CC}, \ \overline{CE} \geq V_{IH}, \\ \mbox{V}_{IN} \geq V_{IH} \ \mbox{or} \ \ V_{IN} \leq V_{IL}, \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \$	AX	-	100	mA
I _{SB2}	Automatic CE Power-down Current – CMOS Inputs	$\begin{array}{l} \underline{\text{Max}} \ \text{V}_{\text{CC}}, \\ \hline{\text{CE}} \geq \text{V}_{\text{CC}} - 0.3 \ \text{V}, \\ \text{V}_{\text{IN}} \geq \text{V}_{\text{CC}} - 0.3 \ \text{V}, \\ \text{or} \ \text{V}_{\text{IN}} \leq 0.3 \ \text{V}, \ \text{f} = 0 \end{array}$	Commercial / Industrial	-	50	mA

Notes

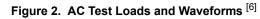
3. V_{II} (min) = -2.0 V for pulse durations of less than 20 ns. 4. CE refers to a combination of CE₀, CE₁, and CE₂. CE is active LOW when all three of these signals are active LOW at the same time.

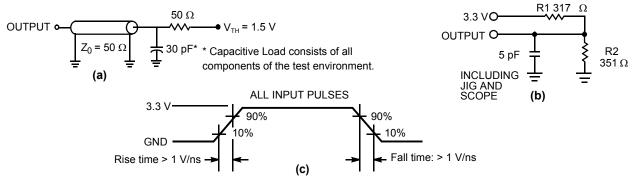


Capacitance

Parameter ^[5]	Description	Test Conditions	Max	Unit
C _{IN}	Input Capacitance	T _A = 25 °C, f = 1 MHz, V _{CC} = 3.3 V	8	pF
C _{OUT}	I/O Capacitance		10	pF

AC Test Loads and Waveforms





Notes

- Tested initially and after any design or process changes that may affect these parameters.
 Valid SRAM operation does not occur until the power supplies have reached the minimum operating V_{DD} (3.0 V). As soon as 1 ms (T_{power}) after reaching the minimum operating V_{DD}, normal SRAM operation can begin including reduction in V_{DD} to the data retention (V_{CCDR}, 2.0 V) voltage.



AC Switching Characteristics

Over the Operating Range

D [7]	Description	-	-8		
Parameter ^[7]	Description	Min	Max	Unit	
Read Cycle			•	•	
t _{power} ^[8]	V _{CC} (typical) to the first access	1	-	ms	
t _{RC}	Read Cycle Time	8	_	ns	
t _{AA}	Address to Data Valid	-	8	ns	
t _{OHA}	Data Hold from Address Change	3	-	ns	
t _{ACE}	\overline{CE}_1 , \overline{CE}_2 , and \overline{CE}_3 LOW to Data Valid	-	8	ns	
t _{DOE}	OE LOW to Data Valid	-	5	ns	
t _{LZOE}	OE LOW to low Z ^[9]	1	_	ns	
t _{HZOE}	OE HIGH to high Z ^[9]	-	5	ns	
t _{LZCE}	\overline{CE}_1 , \overline{CE}_2 , and \overline{CE}_3 LOW to low $Z^{[9]}$	3	_	ns	
t _{HZCE}	\overline{CE}_1 , \overline{CE}_2 , or \overline{CE}_3 HIGH to high $Z^{[9]}$	-	5	ns	
t _{PU}	$\overline{CE}_{1}, \overline{CE}_{2}, \text{ and } \overline{CE}_{3} \text{ LOW to power-up}^{[10]}$	0	_	ns	
t _{PD}	\overline{CE}_{1} , \overline{CE}_{2} , or \overline{CE}_{3} HIGH to power-down ^[10]	_	8	ns	
t _{DBE}	Byte Enable to Data Valid	_	5	ns	
t _{LZBE}	Byte Enable to low Z ^[9]	1	_	ns	
t _{HZBE}	Byte Disable to high Z ^[9]	-	5	ns	
Write Cycle ^{[11,}	12]			•	
t _{WC}	Write Cycle Time	8	_	ns	
t _{SCE}	\overline{CE}_1 , \overline{CE}_2 , and \overline{CE}_3 LOW to Write End	6	_	ns	
t _{AW}	Address Set-up to Write End	6	_	ns	
t _{HA}	Address Hold from Write End	0	_	ns	
t _{SA}	Address Set-up to Write Start	0	_	ns	
t _{PWE}	WE Pulse Width	6	_	ns	
t _{SD}	Data Set-up to Write End	5	_	ns	
t _{HD}	Data Hold from Write End	0	_	ns	
t _{LZWE}	WE HIGH to low Z ^[13]	3	_	ns	
t _{HZWE}	WE LOW to high Z ^[13]	_	5	ns	
t _{BW}	Byte Enable to End of Write	6	-	ns	

Notes

10. These parameters are guaranteed by design and are not tested. 11. The internal write time of the memory is defined by the overlap of \overline{CE}_1 , \overline{CE}_2 , and \overline{CE}_3 LOW and \overline{WE} LOW. The chip enables must be active and \overline{WE} must be LOW to initiate a write, and the transition of any of these signals can terminate the write. The input data set-up and hold timing should be referenced to the leading edge of the signal that terminates the write.

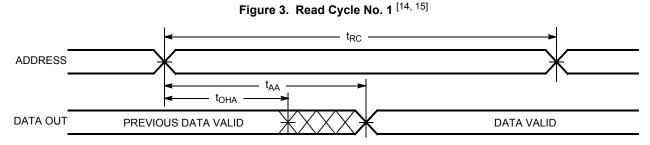
The minimum write cycle time for Write Cycle No. 3 (WE controlled, OE LOW) is the sum of t_{HZWE} and t_{SD}.
 t_{HZOE}, t_{HZCE}, t_{HZWE}, t_{HZBE}, and t_{LZOE}, t_{LZCE}, t_{LZWE}, t_{LZBE} are specified with a load capacitance of 5 pF as in part (b) of Figure 2 on page 5. Transition is measured ±200 mV from steady-state voltage.

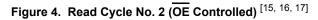
^{7.}

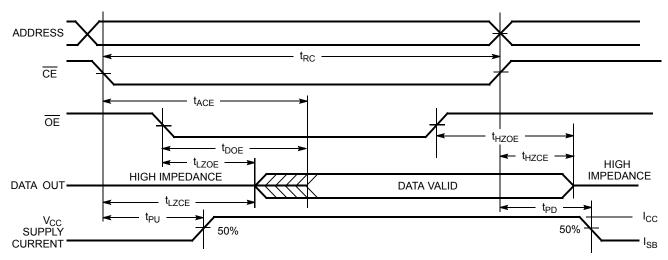
Test conditions assume signal transition time of 3 ns or less, timing reference levels of 1.5 V, input pulse levels of 0 to 3.0 V, and output loading of the specified I_{OL}/I_{OH} and transmission line loads. Test conditions for the read cycle use output loading as shown in part (a) of the Figure 2, unless specified otherwise. This part has a voltage regulator which steps down the voltage from 3 V to 2 V internally. t_{power} time has to be provided initially before a read/write operation is started. t_{HZOE} , t_{HZCE} , t_{HZWE} , t_{HZBE} , and t_{LZOE} , t_{LZWE} , t_{LZBE} are specified with a load capacitance of 5 pF as in part (b) of Figure 2. Transition is measured ±200 mV from steady-state voltage. 8. 9.



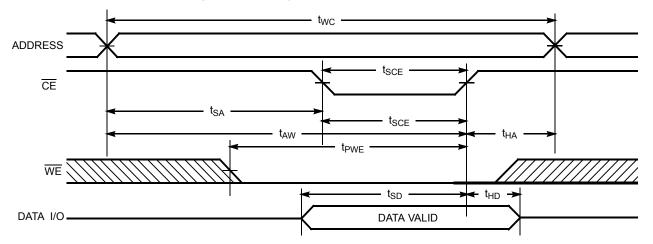
Switching Waveforms











Notes

- Notes

 14. Device is continuously selected. \overrightarrow{OE} , \overrightarrow{CE} = V_{IL}.

 15. WE is HIGH for read cycle.

 16. Address valid prior to or coincident with \overrightarrow{CE} transition LOW.

 17. \overrightarrow{CE} refers to a combination of \overrightarrow{OE}_0 , \overrightarrow{CE}_1 , and \overrightarrow{CE}_2 . \overrightarrow{CE} is active LOW when all three of these signals are active LOW at the same time.

 18. Data I/O is high impedance if $\overrightarrow{OE} = V_{IL}$.

 19. If \overrightarrow{CE} goes HIGH simultaneously with WE going HIGH, the output remains in a high-impedance state.



Switching Waveforms (continued)

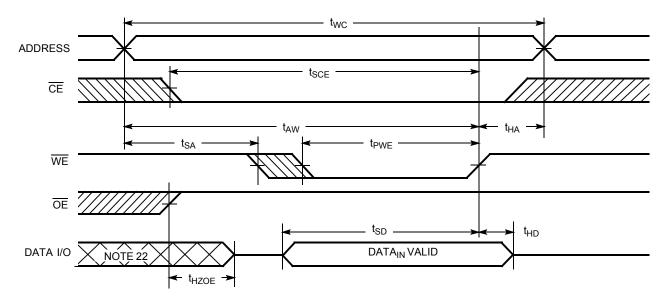
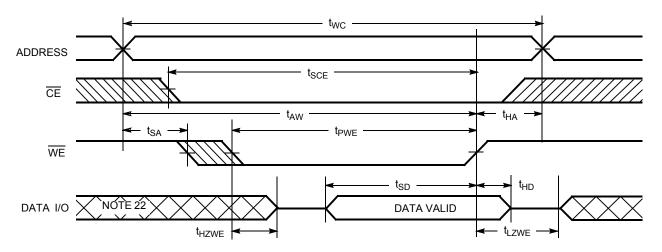


Figure 6. Write Cycle No. 2 (WE Controlled, OE HIGH During Write) ^[20, 21]

Figure 7. Write Cycle No. 3 (WE Controlled, OE LOW) ^[21, 23]



Notes

- 20. Data I/O is high impedance if $\overline{OE} = V_{IL}$. 21. If \overline{CE} goes HIGH simultaneously with WE going HIGH, the output remains in a high-impedance state.

22. During this period the I/Os are in the output state and input signals should not be applied. 23. CE refers to a combination of CE_0 , CE_1 , and CE_2 . CE is active LOW when all three of these signals are active LOW at the same time.



Truth Table

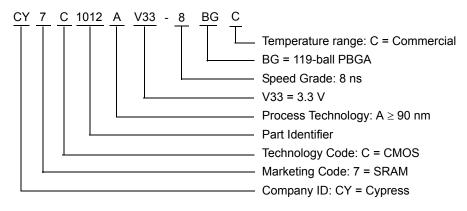
CE0	CE ₁	CE ₂	OE	WE	I/O ₀ -I/O ₂₃	Mode	Power
Н	Н	Н	Х	Х	High Z	Power-down	Standby (I _{SB})
L	Н	Н	L	Н	I/O ₀ –I/O ₇ Data Out	Read	Active (I _{CC})
Н	L	Н	L	Н	I/O ₈ –I/O ₁₅ Data Out	Read	Active (I _{CC})
Н	Н	L	L	Н	I/O ₁₆ –I/O ₂₃ Data Out Read		Active (I _{CC})
L	L	L	L	Н	Full Data Out	Read	Active (I _{CC})
L	Н	Н	Х	L	I/O ₀ –I/O ₇ Data In	Write	Active (I _{CC})
Н	L	Н	Х	L	I/O ₈ –I/O ₁₅ Data In	Write	Active (I _{CC})
Н	Н	L	Х	L	I/O ₁₆ –I/O ₂₃ Data In Write		Active (I _{CC})
L	L	L	Х	L	Full Data In Write /		Active (I _{CC})
L	L	L	Н	Н	High Z	Selected, Outputs Disabled	Active (I _{CC})



Ordering Information

Speed (ns)	Ordering Code	Package Diagram	Package Type	Operating Range
8	CY7C1012AV33-8BGC	51-85115	119-ball (14 × 22 × 2.4 mm) PBGA	Commercial

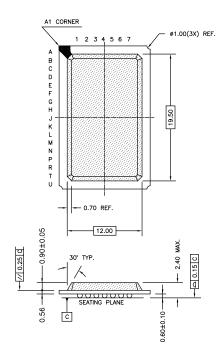
Ordering Code Definitions

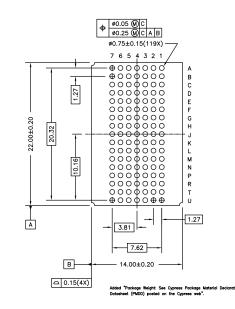




Package Diagram

Figure 8. 119-ball PBGA (14 × 22 × 2.4 mm) BG119 Package Outline, 51-85115





NOTE:

Package Weight: See Cypress Package Material Declaration Datasheet (PMDD) posted on the Cypress web.

51-85115 *D



Acronyms

Acronym	Description		
CMOS	Complementary Metal Oxide Semiconductor		
CE	Chip Enable		
I/O	Input/Output		
OE	Output Enable		
PBGA	Plastic Ball Grid Array		
SRAM	Static Random Access Memory		
TTL	Transistor-Transistor Logic		
WE	Write Enable		

Document Conventions

Units of Measure

Symbol	Unit of Measure		
°C	degree Celsius		
MHz	megahertz		
μA	microampere		
mA	milliampere		
mm	millimeter		
ms	millisecond		
mV	millivolt		
mW	milliwatt		
ns	nanosecond		
%	percent		
pF	picofarad		
V	volt		
W	watt		





Document History Page

Document Title: CY7C1012AV33, 512 K × 24 Static RAM Document Number: 38-05254					
Rev.	ECN No.	Issue Date	Orig. of Change	Description of Change	
**	113711	03/11/02	NSL	New data sheet.	
*A	117057	07/31/02	DFP	Removed 15-ns bin	
*B	117988	09/03/02	DFP	Added 8-ns bin	
*C	118992	09/19/02	DFP	Change Cin (input capacitance) from 6 pF to 8 pF Change Cout (output capacitance) from 8 pF to 10 pF	
*D	120382	11/15/02	DFP	Final data sheet. Added note 4 to "AC Test Loads and Waveforms"	
*E	492137	See ECN	NXR	Removed 12 ns speed bin from product offering Included note #1 and 2 on page #2 Changed the description of I _{IX} from Input Load Current to Input Leakage Cur- rent in DC Electrical Characteristics table Updated Ordering Information Table	
*F	2896044	03/19/2010	AJU	Updated Ordering Information Table Updated Package Diagram Added Sales, Solutions, and Legal Information	
*G	3097955	11/30/2010	PRAS	Added Ordering Code Definitions. Added Acronyms and Units of Measure. Minor edits.	
*H	3086499	06/07/2011	AJU	Updated Selection Guide (Removed -10 column). Updated DC Electrical Characteristics (Removed -10 column). Updated AC Switching Characteristics (Removed -10 column). Updated in new template.	
*	4212876	12/06/2013	VINI	Updated Package Diagram: spec 51-85115 – Changed revision from *C to *D. Updated in new template. Completing Sunset Review.	
*J	4573215	11/18/2014	VINI	Added related documentation hyperlink in page 1.	



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